## Notice of References Cited Application/Control No. 10/535,142 Examiner Michael Bernshteyn Applicant(s)/Patent Under Reexamination MIZUTANI ET AL. Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-			
	В	US-			
	С	US-			
	D	US-			
	Έ	US-			
	F	US-			
	G	US-			
	н	US-	-		
	_	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
*	N	JP 08194968 A	07-1996	Japan	ISHII et al.	
*	0	JP 2002092961 A	03-2002	Japan	TOKUDA et al.	
	Р			,		
	α					
	R				·	
	S					
	Ŧ					

## NON-PATENT DOCUMENT'S

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	w	
,	x	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.